

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination
		10/606,834	NAKAHARA ET AL.
Examiner	Art Unit	Thomas L Dickey	2826
			Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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C	US-2002/0131466	09-2002	Salvatore et al.	372/50
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K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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